


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519895	<b>Applicant(s)/Patent Under Reexamination</b>  OKAYAMA ET AL.
	<b>Examiner</b>  Wendler, Eric	<b>Art Unit</b>  2824

SEARCHED			
Class	Subclass	Date	Examiner
365	232	4/30/2007	EJW
365	57	4/30/2007	EJW
307	91	4/30/2007	EJW
174	32	4/30/2007	EJW

SEARCH NOTES		
Search Notes	Date	Examiner
see attached EAST search history	4/30/2007	EJW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner